Measurement Report

Construction Si	te / Building:					
Processor:						
Used Coating F	Product:					
Date:		Measured by:				
Measuring Device:			Approved by:			
	Elen	nent 1	Element 2	Element 3		

Target value dry film thicknes	ss (µm)						
Measuring points		Measured DFT (µm)	Target value reached?	Measured DFT (μm)	Target value reached?	Measured DFT (μm)	Target value reached?
	1						
	2						
	3						
	4						
	5						

		Element 4		Element 5		Element 6	
Target value dry film thicknes	ss (µm)						
Measuring points		Measured DFT (μm)	Target value reached?	Measured DFT (µm)	Target value reached?	Measured DFT (μm)	Target value reached?
	1						
	2						
	3						
	4						
	5						